



MICROCIRCUIT DATA SHEET

MNDM54LS30-X REV 1A0

Original Creation Date: 04/22/98
Last Update Date: 06/16/98
Last Major Revision Date: 04/22/98

8-INPUT NAND GATE

General Description

This device contains a single gate which performs the logic NAND function.

Industry Part Number

54LS30

Prime Die

L030

NS Part Numbers

DM54LS30E/883
DM54LS30J/883
DM54LS30W/883

Processing

MIL-STD-883, Method 5004

Quality Conformance Inspection

MIL-STD-883, Method 5005

Subgrp	Description	Temp (°C)
1	Static tests at	+25
2	Static tests at	+125
3	Static tests at	-55
4	Dynamic tests at	+25
5	Dynamic tests at	+125
6	Dynamic tests at	-55
7	Functional tests at	+25
8A	Functional tests at	+125
8B	Functional tests at	-55
9	Switching tests at	+25
10	Switching tests at	+125
11	Switching tests at	-55

Features

(Absolute Maximum Ratings)

(Note 1)

Storage Temperature	-65 C to +150 C
Ambient Temperature under Bias	-55 C to +125 C
Input Voltage	-0.5V to +10.0V
VCC Pin Potential to Ground Pin	-0.5V to +7.0V
Junction Temperature under Bias	-55 C to +175 C
Current Applied to Output in LOW state (Max)	twice the rated I _{ol} (ma)

Note 1: Absolute Maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Recommended Operating Conditions

Free Air Ambient Temperature Military	-55 C to +125 C
Supply Voltage Military	+4.5V to +5.5V

Electrical Characteristics

DC PARAMETER

(The following conditions apply to all the following parameters, unless otherwise specified.)
DC: VCC 4.5V to 5.5V, Temp range: -55C to 125C

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
IIH	Input High Current	VCC=5.5V, VM=2.7V, VINL=0.0V	1, 3	INPUTS		20.0	uA	1, 2, 3
IBVI	Input High Current	VCC=5.5V, VM=10.0V, VINL=0.0V	1, 3	INPUTS		100	uA	1, 2, 3
IIL	Input LOW Current	VCC=5.5V, VM=0.4V, VINH=4.5V	1, 3	INPUTS	-0.03	-0.4	mA	1, 2, 3
VOL	Output LOW Voltage	VCC=4.5V, VIH=2.0V, IOL=4.0mA, VIL=0.7V	1, 3	OUTPUTS		0.4	V	1, 2, 3
VOH	High Level Output Voltage	VCC=4.5V, VIL=0.7V, VIH=2.0V, IOH=-0.4mA	1, 3	OUTPUTS	2.5		V	1, 2, 3
IOS	Short Circuit Output Current	VCC=5.5V, VINL=0.0V, VOUT=0.0V	1, 3	OUTPUTS	-20.0	-100	mA	1, 2, 3
VCD	Input Clamp Diode Voltage	VCC=4.5V, IM=-18mA, VINH=4.5V	1, 3	INPUTS		-1.5	V	1, 2, 3
ICCH	Supply Current	VCC=5.5V, VINL=0.0V	1, 3	VCC		500	uA	1, 2, 3
ICCL	Supply Current	VCC=5.5V, VINH=4.5V	1, 3	VCC		1.1	mA	1, 2, 3

AC PARAMETER - 15pF

(The following conditions apply to all the following parameters, unless otherwise specified.)
AC: CL=15pF, RL=2k ohms Temp range: +25C

tpLH	Propagation Delay	VCC=5.0V	2, 4	In to On		12.0	ns	9
tpHL	Propagation Delay	VCC=5.0V	2, 4	In to On		20.0	ns	9

AC PARAMETER - 50pF

(The following conditions apply to all the following parameters, unless otherwise specified.)
AC: CL=50pF, RL=2k ohms Temp range: -55C to +125C

tpLH	Propagation Delay	VCC=5.0V	5	In to On	2.0	20.0	ns	9
			5	In to On	2.0	32.0	ns	10, 11
tpHL	Propagation Delay	VCC=5.0V	5	In to On	2.0	28.0	ns	9
			5	In to On	2.0	38.0	ns	10, 11

Note 1: Screen tested 100% on each device at -55C, +25C & +125C temperature, subgroups A1, 2, 3, 7 & 8.

Note 2: Screen tested 100% on each device at +25C temperature only, subgroup A9.

(Continued)

- Note 3: Sample tested (Method 5005, Table 1) on each MFG. lot at +25C, +125C & -55C temperature, subgroups A1, 2, 3, 7 & 8.
- Note 4: Sample tested (Method 5005, Table 1) on each MFG. lot at +25C, subgroup A9.
- Note 5: Guaranteed, not tested.

Revision History

Rev	ECN #	Rel Date	Originator	Changes
1A0	M0001235	06/16/98	Linda Collins	Initial MDS release: MNDM54LS30-X Rev. 1A0. Added note 4 to the AC (15pF) notes reference column. Deleted the phrase 'and periodically at +125C & -55C, subgroups 10 & 11' from note 4.